

Search Notes

Application/Control No.

10/511,717

Examiner

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Applicant(s)/Patent under
Reexamination

KEMPSELL ET AL.

Art Unit

3643

SEARCHED

Class	Subclass	Date	Examiner
54	44.7 44.1	3/31/2007	STN
	44.3 44.4		
D30	135		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IPC foreign search, see printouts	3/31/2007	STN
text search, see printouts	3/31/2007	STN